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	i pc	2	4	0	4	1	3	8	Oct. 6, 1941	Mayer, A.L.		95	94
AO EMARI	7/4	3	5	2	0	6	8	9	Jul. 14,1970	Nagae et al. SE	P I 2	29811	55
10	14	3	5	2	0	6	9	0	Jul. 14, 1970	Nagae et al.		96	55
	PL	3	5	8	7	4	3	5	Jun. 28, 1971	Chioffe Technol	ogy Ce	mg 2600	89
	1/2	3	6	1	5	4	7	9	Oct. 26, 1971	Kohler et al.		96	48
	94	3	6	1	5	4	9	8	Oct. 26, 1971	Aral		96	55
	16	3	6	1	7	2	8	2	Nov. 2, 1971	Bard	_	96	59
	14	3	7	4	7	1	2	0	Jul 17, 1973	Stemme		346	75
	1/4	3	9	0	3	5	4	1	Sep. 2, 1975	Von Meister et al		354	317
	PL	3	9	4	6	3	9	8	Mar 23, 1976	Kyser et al.		346	1
	pa	3	9	5	9	0	4	8	May 25, 1976	Stanfield et al.		156	94
	14	4	0	2	6	7	5	6	May 31, 1977	Stanfield et al.		156	554
	Ph	4	0	8	1	5	7	7	Mar. 28, 1978	Horner		427	424
	PL	4	1	4	2	1	0	7	Feb. 27, 1979	Hatzakis et al.		250	571
	pζ	4	2	1	5	9	2	7	Aug. 5, 1980	Grant et al.		354	317
	PL	4	2	4	9	9	8	5	Feb. 10, 1981	Stanfield		156	554
	PL	4	3	0	1	4	6	9	Nov. 17, 1981	Modeen et al.		358	75
	PL	4	4	9	0	7	2	9	Dec. 25, 1984	Clark et al.		346	75
	٩٤	4	5	0	1	4	8	0	Feb. 26, 1985	Matsui et al.		354	298
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	14	wo 9	98/25	399					Jun. 11, 1998	PCT		H04N	1/38
	14	wo 9	98/31	142					Jul. 16, 1998	PCT		H04N	5/253
	PC	wo 9	98/34	157					Aug. 6, 1998	PCT		G03D	•
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	14	Resol	lution	Car	diac I	mage	s", Do	oyle,	M., et al., 8306 M	agnetic Resonance	in Med	licine 31, No	o. 5,
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	14	"Ani	sotro	pic S _I	pectra	l Mag	gnitud	le Es	timation Filters fo	r Noise Reduction a	nd Ima	ige Enhance	ement",
		Aich,	T., e	t al.,	Philip	s Gn	bH R	esea	rch Laboratories, I	EEE, pp. 335-338,	1996.		
	14									by signal-dependen	t noise	", Rangayya	an, R., et
									pp. 4477-4487, Ju				
	14									ges, Photographic N			
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		Stim	oson,	D., e	t al., I	Resea	rch Re	epor	ts, BioTechniques,	Vol. 25, No. 5, pp.	886-89	90, 1998.	
	14									nk-Jet Printing Tec	hnolog	y", Hayes, l	D. et al.,
L									ologies, Inc., pp. 1				
	14									Applications", Wall			-
		Tech	nolog	ies, I	nc., L	<u>abor</u> a	tory A	Auto	mation News, Vol.	1, No. 5, pp. 6-9, N	lov., 19	996.	
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FIRAC	EM.	14	4	6	2	1	0	3	7	Nov. 4, 1986	Kanda et al.		430	30
	<u> </u>	14	4	6	2	3	2	3	6	Nov. 18, 1986	Stella		354	318
		14	4	6	3	6	8	0	8	Jan. 13, 1987	Herron		346	75
	<u> </u>	14	4	6	6	6	3	0	7	May 19, 1987	Matsumoto et a	ıl	356	404
		K	4	6	7	0	7	7	9	Jun 2, 1987	Nagano		358	75
		PL	4	7	3	6	2	2	1	Apr. 5, 1988	Shidara		354	317
		14	4	7	4	5	0	4	0_	May 17, 1988	Levine		430	21
•		14	4	7	5	5	8	4	4	Jul. 5, 1988	Tsuchiya et al.		354	317
		14	4	7	7	7	1	0	2	Oct. 11, 1988	Levine		430	21
		PL	4	7_	9	6	0	6	1	Jan. 3, 1989	Ikeda et al.		355	73
		86	4	8	1	4	6	3	0	Mar. 21, 1989	Lim		250	578
		PL	4	8	2	1	1	1	4	Apr. 11, 1989	Gebhardt		358	75
		Ph	4	8	4	5	5	5	1	Jul. 4, 1989	Matsumoto		358	80
		Ph	4	8	5	1	3	1	1	Jul. 25, 1989	Millis et al.		430	30
		Ph	4	8	5	7	4	3	0	Aug. 15, 1989	Millis et al.		430	30
		PL	4	8	7	5	0	6	7	Oct. 17, 1989	Kanzaki et al.		354	325
		86	4	9	6	9	0	4	5	Nov. 6, 1990	Haruki et al.		358	228
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		1'								I Meeting, pp. 1-9			_	
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		114	www	<u>/.nikc</u>	nusa	.com/i	<u>refere</u>	nce/w	hitep	apers/imaging, N	ikon Corporation	, Nov. 28	, 2000.	
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P		16	5	0	3	4	7	6	7	Jul. 23, 1991	Netz et al.		3434 center	2600
		14	5	1	0_	1	2	8	6	Mar. 31, 1992	Patton		358	487
		84	5	1	2	4	2	1	6	Jun. 23, 1992	Giapis et al.		430	30
		14	5	1	5	5	5	9	6	Oct. 13, 1992	Kurtz et al.		358	214
		14	5	1	9	6	2	8	5	Mar. 23, 1993	Thomson		430	30
į		14	5	2	1	2	5	3	2	May 18, 1993	Shiota Talahashi at al		354	319
	-	14	5	2	3	5	3	5	9	Jul. 27, 1993 Aug. 10, 1993	Takahashi et al. Pies et al.		354 346	313 140
		16	5	$\frac{2}{2}$	5	5	4	0	8	Oct. 26, 1993	Blackman		15	308
		PL	5	2	6	6	8	0	5	Nov. 30, 1993	Edgar		250	330
		14	5	2	6	7	0	3	0	Nov. 30, 1993	Giorgianni et al.		358	527
		16	5	2	9	2	6	0	5	Mar. 8, 1994	Thomson	-	430	30
		OL	5	2	9	6	9	$\frac{3}{2}$	$\frac{3}{3}$	Mar. 22, 1994	Hung		358	527
		PL	5	3	5	0	6	5	1	Sep. 27, 1994	Evans et al.		430	21
		14	5	3	5	0	6	6	4	Sep. 27, 1994	Simons		430	362
		OC	5	3	5	7	3	0	7	Oct. 18, 1994	Glanville et al.		354	324
		14	5	3	6	0	7	0	1	Nov. 1, 1994	Elton et al.		430	501
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	354	298
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1 5 4 4 8 3 8 0 Sep. 5, 1995 Park	358	520
1/4 5 4 5 2 0 1 8 Sep. 19, 1995 Capitant et al.	348	651
6 5 4 6 5 1 5 5 Nov. 7, 1995 Edgar	358	500
1/2 5 5 1 6 6 0 8 May 14, 1996 Hobbs et al.	430	30
1 5 5 4 6 4 7 7 Aug. 13, 1996 Knowles et al.	382	242
1/4 5 4 9 6 6 6 9 Mar. 5, 1996 Pforr et al.	430	22
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1 1 2 1 2 1 2 1 2 1 2 1 2 1 2 1 2 1 2 1	358	471
1/2 5 5 5 2 9 0 4 Sep. 3, 1996 Ryoo et al.	358	518
1 5 5 6 3 7 1 7 Oct. 8, 1996 Koeng et al.	358	406
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	14	5	5	9	6	4	1	5	Jan. 21, 1997	Cosgrove et al.		358	296	
<u> </u>	1/2	5	6	2	7	0	1	6	May 6, 1997	Manico		430	434	
<u> </u>	14	5	6	6	4	2	5	3	Sep. 2, 1997	Mevers		396	603	
<u> </u>	1/4	5	6	6	4	2	5	5	Sep. 2, 1997	Wen		396	627	
	14	5	6	6	7	9	4	4	Sep. 16, 1997	Reem et al.		430	359	
	16	5	6	7	8	1	1	6	Oct. 14, 1997	Sugimoto et al.		396	611	
	1/2	5	6	9	1	1	1	8	Nov. 25, 1997	Haye	-	430	357	
	14	5	6	9	5	9	1	4	Dec. 9, 1997	Simon et al.	-	430	379	
	1/4	5	6	9	8	3	8	2	Dec. 16, 1997	Nakahanada et	al.	430	418	
	1 1/2	5	17	2	6	7	7	3	Mar. 10, 1998	Mehlo et al.		358	.474	
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-	1/2	5	17	7	1	1	0	7	Jun. 23, 1998	Fujimoto et al.		358	464	
	1/4	5	7	9	0	2	7	7	Aug. 4, 1998	Edgar		358	487	
	1/2	5	8	3	5	8	1	1	Nov. 10, 1998	Tsumura		396	598	
	1//2	5	8	7	0	1	7	2	Feb. 9, 1999	Blume		355	27	
	PL	5	8	8	0	8	1	9	Mar. 9, 1999	Tanaka et. Al.		355	75	
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- 	14	5	9	3	0	3	8	8	Jul. 27, 1999	Murakami et al.		382 4 21	JU167
3,	16	5	9	6	3	6	6	2	Oct. 5, 1999	Vachtsevanos et Keith et al.	aTechno	103820anta	150
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	14	5	9	7	9	0	1	1	Nov. 9, 1999	Miyawaki et al.		15	308
-	18	5	9	8	2	9	3	6	Nov. 9, 1999	Tucker et al.		382	233
	1/4	5	9	8	2	9	3	7	Nov. 9, 1999	Accad		382	239
	1/4	5	9	8	2	9	4	1	Nov. 9, 1999	Loveridge et al.		382	260
	1/2	5	9	8	2	9	5	1	Nov. 9, 1999	Katayama et al.		382	284
	1/2	5	9	8	8	8	9	6	Nov. 23, 1999	Edgar		396	604
	1/2	5	9	9	1	4	4	4	Nov. 23, 1999	Burt et al.		382	232
	14	5	9	9	8	1	0	9	Dec. 7, 1999	Hirabayashi		430	434
	12	6	0	0	0	2	8	4	Dec. 14, 1999	Shin et al.		73	150
	12	6	0	0	5	9	8	17	Dec. 21, 1999	Nakamura et al.		382	294
	12	6	0	6	5	8	2	4	May 23, 2000	Bullock et al.		347	19
	1/2	6	0	6	9	7	1	4	May 30, 2000	Edgar		358	487
	1/4	6	0	8	9	6	8	17	Jul. 18, 2000	Helterline		347	1 7
-	12/	6	1	0	1	2	7	3	Aug. 8, 2000	Matama		382	169
	74	6	1	0	2	5	0	8	Aug. 15, 2000	Cowger		347	17
	PL	6	1	3	7	9	6	5	Oct. 24, 2000	Burgeios et al.		396	626
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